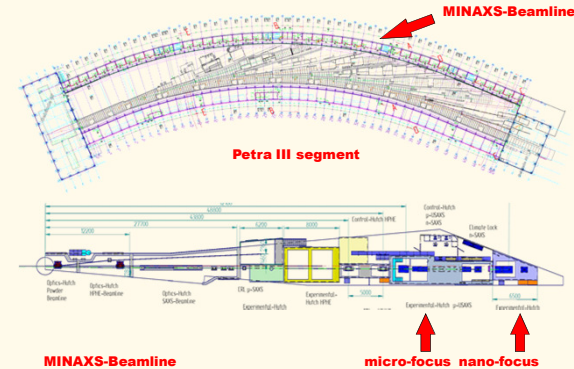
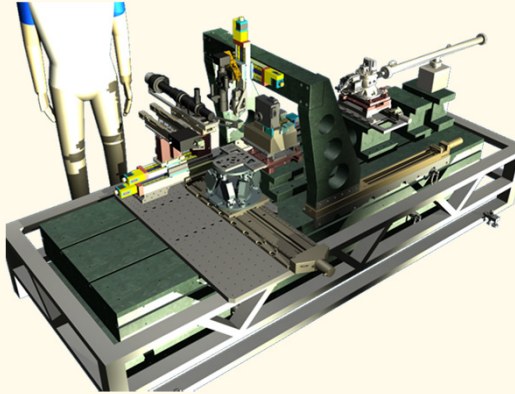


Beamline



Top: Position of the Micro and Nanofocus X-ray Scattering (MINAXS) beamline within the layout of *Petra III*. **Bottom:** The nanofocus hutch is located downstream the microfocus endstation, both of which are fed by a canted undulator.



Preliminary model of the **nanofocus sample stage**, mounted onto a heavy, vibration reductive, two-segment monolith optical table.



Micropositioning devices for the alignment of the sample and nanofocusing optical elements. Hexapods provide 3 linear and 3 rotational degrees of freedom with a freely definable pivot point. The top-mountable XZ-stage provides superior spatial resolution.

Type	P-611 XZ stage	F-206 hexapod	M-824 hexapod
max. load	1.5 kg	2 kg	10 kg
travel range	±100 µm	±6 mm, ±6°	±22.5 mm, ±12.5°
resolution	< 10 nm	100 nm, 2 µrad	300 nm, 3.5 µrad

Optics

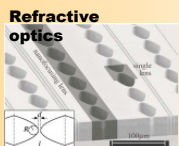
Focusing x-rays down to the **sub-µm** range (nanofocusing) requires high precision optical elements and a well defined x-ray. Once vibration issues are carefully taken care of, the incoming beam can be focused to a size close to the diffraction limit (around 20 nm).

As shown **right** and **below** many types of optics exist, the choice of which depends on the main concern of the experiment – always being a trade-off between conserving flux, spatial resolution and coherence.

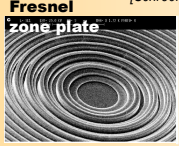
Focusing Optics for Hard X-rays: 6 - 60 (200) keV					
	REFLECTIVE	REFLECTIVE	REFRACTIVE	REFRACTIVE	REFRACTIVE
	Kirkpatrick Baez systems	Capillaries	Waveguides	Fresnel Zone plates	Refractive lenses
Energy	6-60 keV	6-60 keV	6-60 keV	6-60 keV	6-60 keV
Bandwidth	wide band	wide band	wide band	wide band	wide band
Resolution	25 nm	41-45 nm	40-25 nm	30 nm	50 nm
Flux	+++	+++	---	---	---
Coherence	YES	NO	YES	NO	NO
Length	NO	NO	YES	YES	YES
Easy to use	AC	AC	AC	AC	AC

[Mocuta]

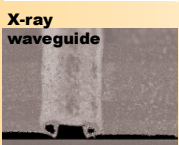
Small focus, high coherence



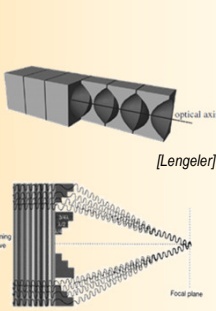
[Schroer]



[Lengeler]

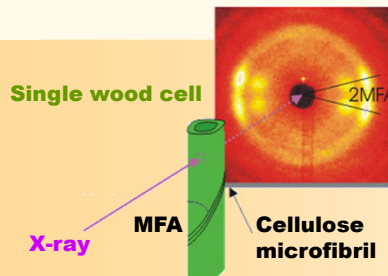


[Metzger]

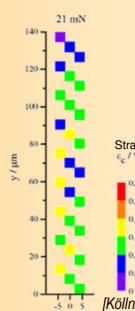
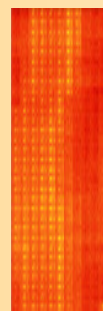
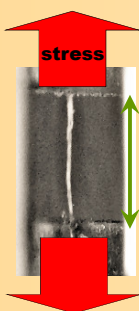


[Pfeiffer]

high acceptance and flux

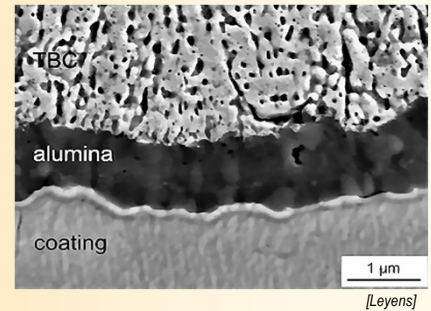
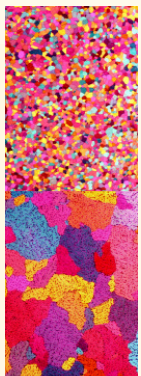


Top: Microdiffraction experiment on a wood cell with the cellulose (200) reflection being an indicator for the microfibril angle (MFA). **Bottom:** (left) Actual experiment, the cell is exposed to lateral stress during irradiation. Combined with a µm-sized x-ray spot the intracellular strain distribution (right) can be determined from the measured MFA-distribution (middle). Yet smaller foci allow for investigation of more finely structured materials, such as fibres, smaller cells etc.



Nanofocus diffraction is complementary to TEM and SAXS/SANS as it allows for *in situ* experiments (e.g. temperature, mechanical load) to access single grains of polycrystalline materials on a sub-µm length-scale. **Right:** Microstructure of Mg-Al-Zn alloy with & w/o SiC [courtesy of GKSS].

Bottom: A thermal barrier coating (TBC) deposited onto aluminidecoated TiAl alloy Ti-45Al-8Nb. TEM evidenced protective alumina scale formation on TiAl₃, providing good adherence of the TBC. If crystallisation or composition of such structures is in question, sub-µm diffraction and spectroscopy methods are beneficial.



[Leyens]

Science

References

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